

IEC SYSTEM FOR CONFORMITY TESTING  
AND CERTIFICATION OF ELECTRICAL  
EQUIPMENT (IECEE)  
CB SCHEME

SYSTÈME CEI D'ESSAIS DE CONFORMITÉ  
ET DE CERTIFICATION DES EQUIPEMENTS  
ELECTRIQUE (IECEE)  
METHODE OC

## CB TEST CERTIFICATE CERTIFICAT D'ESSAI OC

Product  
*Produit*

Name and address of the applicant  
*Nom et adresse du demandeur*

Name and address of the manufacturer  
*Nom et adresse du fabricant*

Name and address of the factory  
*Nom et adresse de l'usine*

Rating and principal characteristics  
*Valeurs nominales et caractéristiques principales*

Trade mark (if any)  
*Marque de fabrique (si elle existe)*

Model/type Ref.  
*Ref. de type*

Additional information (if necessary)  
*Information complémentaire (si nécessaire)*

A sample of the product was tested and found  
to be in conformity with  
*Un échantillon de ce produit a été essayé et a été  
considéré conforme à la*

as shown in the Test Report Ref. No.  
which form part of this certificate  
*comme indiqué dans le Rapport d'essais numéro  
de référence  
qui constitue une partie de ce certificat*

This CB Test Certificate is issued by the National Certification Body  
*Ce Certificat d'essai OC est établi par l'Organisme National de Certification*

### Switching Power Supply

I-Star Computer Co., Ltd.  
2F, No. 33, Lane 42  
Chung Shin North St., SAN CHUNG, TAIPEI HSIEN 241, TAIWAN,  
R.O.C.

I-Star Computer Co., Ltd.  
2F, No. 33, Lane 42  
Chung Shin North St., SAN CHUNG, TAIPEI HSIEN 241, TAIWAN,  
R.O.C.

I-Star Computer Co., Ltd.  
2F, No. 33, Lane 42  
Chung Shin North St., SAN CHUNG, TAIPEI HSIEN 241, TAIWAN,  
R.O.C.

Input Rating : refer to the test report  
Output Rating : refer to the test report  
Protection Class: I

1,2) not shown  
3,4) Trademark of IPS

- 1) TC-230P ATX, TC-250P ATX, TC-300P ATX, TC-350P ATX
- 1) TC-400P ATX, TOP-400SSA, TC-300R, TC-350R, TC-400R
- 2) IPS-250, IPS-300, IPS-350, IPS-400
- 3) TC-1U20, TC-2U30, TC-2U35, TC-2U40
- 4) IPS-1U20, IPS-2U30, IPS-2U35, IPS-2U40

For differences between the models, refer to the test report.

### PUBLICATION

IEC 60950:1991+A1+A2+A3+A4  
inclusive CENELEC Common Modifications  
National differences see test report

### EDITION

12001979 001



TÜV Rheinland Japan Ltd.  
3-19-5 Shin-Yokohama  
222-0033 Japan

Date 20.03.2002

Signature

Dipl.-Ing. M. Lechtermann